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N04Q16yyC2B

Advance Information

4Mb Ultra-Low Power Asynchronous CMOS SRAM w/ Dual Vcc and VccQ for Ultimate Power Reduction 256K×16 bit POWER SAVER TECHNOLOGY

Overview

The N04Q16yyC2B are ultra-low power memory devices containing a 4 Mbit Static Random Access Memory organized as 262,144 words by 16 bits. The device is designed and fabricated using NanoAmp's advanced CMOS technology to provide ultra-low active and standby power. The device operates with two chip enable (CE1 and CE2) controls and output enable (OE) to allow for easy memory expansion. Byte controls (UB and LB) allow the upper and lower bytes to be accessed independently. The 4Mb SRAM is optimized for the ultimate in low power and is suited for various applications where ultra-lowpower is critical such as medical applications. battery backup and power sensitive hand-held devices. The unique page mode operation saves active operating power and the dual power supply rails allow very low voltage operation while maintaining 3V I/O capability. The device can operate over a very wide temperature range of 0°C to +70°C for the lowest power and is also available in the industrial range of -40°C to +85°C. The devices are available in standard BGA and TSOP packages. The devices are also available as Known Good Die (KGD) for embedded package applications.

Features

- Multiple Power Supply Ranges
 - 1.1V 1.3V
 - 1.65V 1.95V
 - 2.3V 2.7V
 - 2.7V 3.6V
- Dual Vcc / VccQ Power Supplies
 - 1.2V Vcc with 3V VccQ
 - 1.8V Vcc with 3V VccQ
 - 2.5V Vcc with 3V VccQ
- Very low standby current 50nA typical for 1.2V operation
- Very low operating current 400µA typical for 1.2V operation at 1µs
- Very low Page Mode operating current 80µA typical for 1.2V operation at 1µs
- Simple memory control Dual Chip Enables (CE1 and CE2) Byte control for independent byte operation Output Enable (OE) for memory expansion
- Automatic power down to standby mode
- · BGA, TSOP and KGD options
- RoHS Compliant

Product Options

Part Number	I/O	Typical Standby Current	Vcc (V)	VccQ (V)	Speed (nS)	Typical Operating Current	Operating Temperature
N04Q1612C2Bx-15C	x16	50nA	1.2	1.2, 1.8, 3	150ns	0.4 mA @ 1MHz	
N04Q1618C2Bx-15C	x16	50nA	1.0	10050	150ns	0.4 mA @ 1MHz	
N04Q1618C2Bx-70C	x16	200nA	1.8	1.8, 2.5, 3	70ns	0.6 mA @ 1MHz	0°C to +70°C
N04Q1625C2Bx-15C	x16	800nA	2.5	2.5, 3	150ns	0.6 mA @ 1MHz	
N04Q1630C2Bx-70C	x16	800nA	3.0	3.0	70ns	2.2mA @ 1MHz	

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Pin Configurations (4Mb) 5 3 A4 A3 A2 A1 A0 CE1 I/O0 I/O2 I/O3 VCCQ VSSQ I/O4 I/O5 I/O7 WE A16 A15 A14 A13 A12 LB OE A₂ CE2 CE1 UВ I/O₀ В I/O₈ С I/O₂ I/O₉ A₅ A₆ I/O₁ D I/O₁₁ Vcc Ε F I/O₁₄ I/O₁₃ I/O₆ G WE I/O₇ I/O₁₅ NC NC NC 48 Pin BGA (top) Com.cn **TSOP II**

Pin Descriptions

Pin Name	Pin Function
A ₀ -A ₁₇	Address Inputs
WE	Write Enable Input
CE1	Chip Enable 1 Input
CE2	Chip Enable 2 Input
ŌE	Output Enable Input
LB	Lower Byte Enable Input
UB	Upper Byte Enable Input
I/O ₀ -I/O ₇	Lower Byte Data Input/Output
I/O ₈ -I/O ₁₅	Upper Byte Data Input/Output
V _{CC}	Core Power
V_{CCQ}	Power for I/O
V _{SS}	Core Ground
V_{SSQ}	Ground for I/O
NC	Not Connected

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Functional Block Diagram Word Address Address Inputs Decode Logic (A1 - A4)Input/ Address Word Mux Page 4Mb Output Inputs I/Ò0 - I/O7 Address RAM Array Mux Decode and (A0, A5 - A17) Logic **Buffers** 1/08 - 1/015 Control Logic

Functional Description

CE1	CE2	WE	ŌE	UB ¹	LB ¹	I/O ₀ - I/O ₁₅ ¹	MODE	POWER
Н	Х	Х	X	X	Х	High Z	Standby ²	Standby
X	L	Х	Х	Х	Х	High Z	Standby ²	Standby
L	Н	Х	Х	Н	Н	High Z	Standby	Standby
L	Н	Ш	X^3	L ¹	L ¹	Data In	Write ³	Active
L	Н	Η	Ш	L ¹	L ¹	Data Out	Read	Active
L	Н	Н	Н	L ¹	L ¹	High Z	Active	Active

^{1.} When $\overline{\text{UB}}$ and $\overline{\text{LB}}$ are in select mode (low), I/O $_0$ - I/O $_{15}$ are affected as shown. When $\overline{\text{LB}}$ only is in the select mode only I/O $_0$ - I/O $_7$ are affected as shown. When $\overline{\text{UB}}$ is in the select mode only I/O $_8$ - I/O $_{15}$ are affected as shown.

Capacitance¹

Item	Symbol	Test Condition	Min	Max	Unit
Input Capacitance	C _{IN}	V _{IN} = 0V, f = 1 MHz, T _A = 25°C		8	pF
I/O Capacitance	C _{I/O}	V _{IN} = 0V, f = 1 MHz, T _A = 25°C		8	pF

^{1.} These parameters are verified in device characterization and are not 100% tested

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^{2.} When the device is in standby mode, control inputs ($\overline{\text{WE}}$, $\overline{\text{OE}}$, $\overline{\text{UB}}$, and $\overline{\text{LB}}$), address inputs and data input/outputs are internally isolated from any external influence and disabled from exerting any influence externally.

^{3.} When $\overline{\text{WE}}$ is invoked, the $\overline{\text{OE}}$ input is internally disabled and has no effect on the circuit.

Absolute Maximum Ratings¹

Item	Symbol	Rating	Unit
Voltage on any pin relative to V _{SS}	V _{IN,OUT}	-0.3 to V _{CC} +0.3	V
Voltage on V_{CC} Supply Relative to V_{SS}	V _{CC}	-0.3 to 4	V
Power Dissipation	P _D	500	mW
Storage Temperature	T _{STG}	-40 to 125	°C
Operating Temperature	T _A	-40 to +85	°C
Soldering Temperature and Time	T _{SOLDER}	260°C, 10sec	°C

^{1.} Stresses greater than those listed above may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operating section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Operating Characteristics (Over Specified Temperature Range)

Item	Symbol	Device	Conditions	Min.	Тур	Max	Unit	
		N04Q1612	1.2V Core Device	1.1	1.2	1.3		
Core Supply Voltage	V _{CC}	N04Q1618	1.8V Core Device	1.65	1.8	1.95	V	
Core Supply Voltage	▼CC	N04Q1625	2.5V Core Device	2.3	2.5	2.8	V	
		N04Q1630	3V Core Device	2.7	3.0	3.6		
		N04Q1612	1.2V Core Device	1.1		3.3		
I/O Supply Voltage	Vana	N04Q1618	1.8V Core Device	1.65		3.3	V	
1/O Supply Voltage	Vccq	N04Q1625	2.5V Core Device	2.3		3.3	V	
		N04Q1630	3V Core Device	2.7		3.6		
Input High Voltage	V _{IH}			0.8 x VCCQ		V _{CC} +0.3	V	
Input Low Voltage	V _{IL}			-0.3		0.2 x VCCQ		
Output High Voltage	V _{OH}		I _{OH} = -100uA	V _{CC} -0.2			V	
Output Low Voltage	V _{OL}		I _{OL} = 100uA			0.2	V	
Input Leakage Current	ILI		V _{IN} = 0 to V _{CC}			0.5	μА	
Output Leakage Current	I _{LO}		OE = V _{IH} or Chip Disabled			0.5	μА	

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Power Consumption $(T_A = 0^{\circ}C - 70^{\circ}C)$

Device PN				Speed	Typ ¹	Max	
	Standby Current ²	Isb	Chip Disabled V _{CC} = 1.3V, V _{IN} = V _{CC} or 0		50	500	nA
N04Q1612C2Bx-	D 1847 11 0 13	laa	Chip Enabled, I _{OUT} = 0	1us	0.4	0.5	A
15C	Read/Write Current ³	Icc	V_{CC} =1.3V, V_{IN} = V_{IH} or V_{IL}	150ns	2	3	mA
	Page Mode Current	Iccp	Chip Enabled, I _{OUT} = 0	1us	80	100	μА
	r age Mode Current	ісср	V_{CC} =1.3V, V_{IN} = V_{IH} or V_{IL}	150ns	300	450	μΑ
		Ī		T		T	
	Standby Current	Isb	Chip Disabled V _{CC} = 1.9V, V _{IN} = V _{CC} or 0V		50	500	nA
N04Q1618C2Bx-	Read/Write Current	Icc	Chip Enabled, I _{OUT} = 0	1us	0.4	0.5	mA
15C	read/write ourient	100	V_{CC} =1.9V, V_{IN} = V_{IH} or V_{IL}	150ns	2	3	1117 (
	Page Mode Current	Iccp	Chip Enabled, I _{OUT} = 0	1us	80	100	μΑ
	ago modo odnom	.00p	V _{CC} =1.9V, V _{IN} =V _{IH} or V _{IL}	150ns	400	500	ρυ .
- 1 To							
	Standby Current	Isb	Chip Disabled V _{CC} = 1.9V, V _{IN} = V _{CC} or 0	CIV	0.2	1.5	μΑ
N04Q1618C2Bx-	Read/Write Current	lcc lccp	Chip Enabled, I _{OUT} = 0 V _{CC} =1.9V, V _{IN} =V _{IH} or V _{IL}	1us	0.6	0.9	mA
70C				70ns	6	7	
	Page Mode Current		Chip Enabled, I _{OUT} = 0	1us	0.1	0.2	mA
T age Wode Guitern		ЮОР	V _{CC} =1.9V, V _{IN} =V _{IH} or V _{IL}	70ns	8.0	1	
				Γ		Г	
	Standby Current	Isb	Chip Disabled $V_{CC} = 2.8V$, $V_{IN} = V_{CC}$ or 0		0.8	1.0	μΑ
N04Q1625C2Bx-	Read/Write Current	Icc	Chip Enabled, I _{OUT} = 0	1us	0.6	1.0	mA
15C	Troad/Title Carron	100	V_{CC} = 2.8V, V_{IN} = V_{IH} or V_{IL}	150ns	3	4	1117 (
	Page Mode Current	Iccp	Chip Enabled, I _{OUT} = 0	1us	0.1	0.2	mA
	- age mean camen		V_{CC} = 2.8V, V_{IN} = V_{IH} or V_{IL}	150ns	1.5	2	
	T	Ī		T		T	Ī
	Standby Current	Isb	Chip Disabled $V_{CC} = 3.6V$, $V_{IN} = V_{CC}$ or 0		0.8	4	μΑ
N04Q1630C2Bx-	Read/Write Current	Icc	Chip Enabled, I _{OUT} = 0	1us	2.2	3	mA
70C	. toda, milo odnom	.50	V_{CC} = 3.6V, V_{IN} = V_{IH} or V_{IL}	70ns	8.5	10	
	Page Mode Current	Iccp	Chip Enabled, I _{OUT} = 0	1us	0.5	0.6	mA
	. ago modo odnom	\	V_{CC} = 3.6V, V_{IN} = V_{IH} or V_{IL}	70ns	2	1.5	111/

^{1.} Typical values are measured at Vcc=Vcc Typ., $\rm T_A=25\,^{\circ}C$ and not 100% tested.

^{2.} This device assumes a standby mode if the chip is disabled ($\overline{\text{CE1}}$ high or CE2 low). In order to achieve low standby current all inputs must be within 0.2 volts of either VCC or VSS. This applies to all ISB values.

^{3.} This parameter is specified with the outputs disabled to avoid external loading effects. The user must add current required to drive output capacitance expected in the actual system. This applies to all lcc and lccp values.

Power Savings with Page Mode Operation (WE = V_{IH}) Page Address (A0, A5-A17) Word Address (A1-A4) CE1 CE2 OE LB, UB

Note: Page mode operation is a method of addressing the SRAM to save operating current. The internal organization of the SRAM is optimized to allow this unique operating mode to be used as a valuable power saving feature.

The only thing that needs to be done is to address the SRAM in a manner that the internal page is left open and 16-bit words of data are read from the open page. By treating addresses A1 - A4 as the least significant bits and addressing the 16 words within the open page, power is reduced to the page mode value which is considerably lower than standard operating currents for low power SRAMs.

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Timing Test Conditions

Item	
Input Pulse Level	$0.1 V_{CC}$ to $0.9 V_{CC}$
Input Rise and Fall Time	5ns
Input and Output Timing Reference Levels	0.5 V _{CC}
Output Load	CL = 30pF
Operating Temperature	0 to +70°C

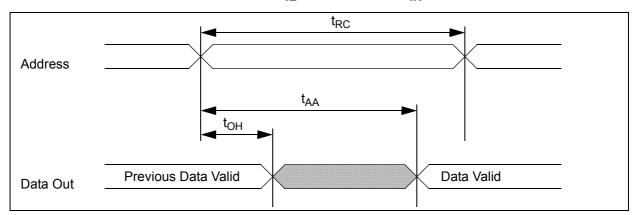
Timing

lta	Cumhal	-7	70	-1	Units	
Item	Symbol	Min.	Max.	Min.	Max.	
Read Cycle Time	t _{RC}	70	4	150		ns
Address Access Time	t _{AA}		70	~	150	ns
Page Mode Address Access Time	t _{AAP}	人為	35	0	75	ns
Chip Enable to Valid Output	t _{CO}	6 3	70		150	ns
Output Enable to Valid Output	toE	-0	35		75	ns
Byte Select to Valid Output	t _{LB,} t _{UB}	.0	70		150	ns
Chip Enable to Low-Z output	t _{LZ}	10		10		ns
Output Enable to Low-Z Output	t _{OLZ}	5		5		ns
Byte Select to Low-Z Output	t _{LBZ} , t _{UBZ}	10		10		ns
Chip Disable to High-Z Output	t _{HZ}	0	20	0	20	ns
Output Disable to High-Z Output	t _{OHZ}	0	20	0	20	ns
Byte Select Disable to High-Z Output	t _{LBHZ} , t _{UBHZ}	0	20	0	20	ns
Output Hold from Address Change	t _{OH}	10		10		ns
Write Cycle Time	t _{WC}	70		150		ns
Chip Enable to End of Write	t _{CW}	50		120		ns
Address Valid to End of Write	t _{AW}	50		120		ns
Byte Select to End of Write	t _{LBW,} t _{UBW}	50		120		ns
Write Pulse Width	t _{WP}	40		100		ns
Address Setup Time	t _{AS}	0		0		ns
Write Recovery Time	t _{WR}	0		0		ns
Write to High-Z Output	t _{WHZ}		20		20	ns
Data to Write Time Overlap	t _{DW}	40		100		ns
Data Hold from Write Time	t _{DH}	0		0		ns
End Write to Low-Z Output	t _{OW}	5		5		ns

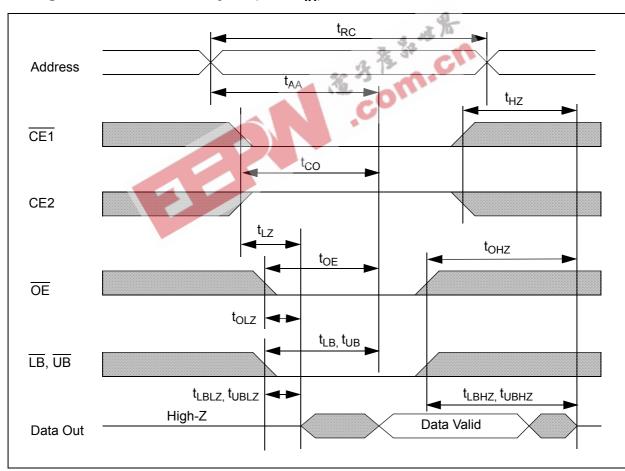
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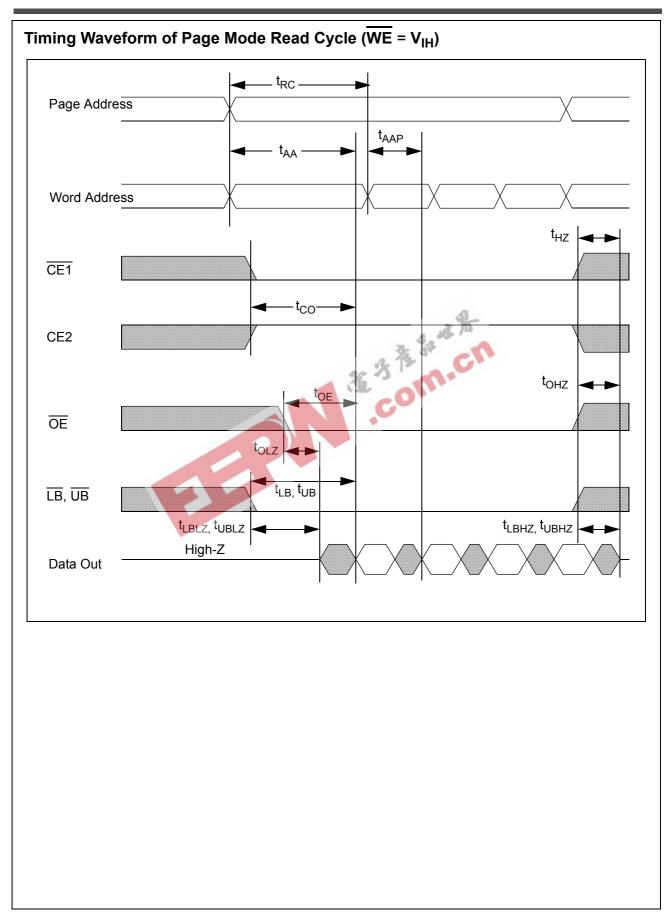
Timing of Read Cycle ($\overline{CE1} = \overline{OE} = V_{IL}$, $\overline{WE} = CE2 = V_{IH}$)



Timing Waveform of Read Cycle (WE=V_{IH})

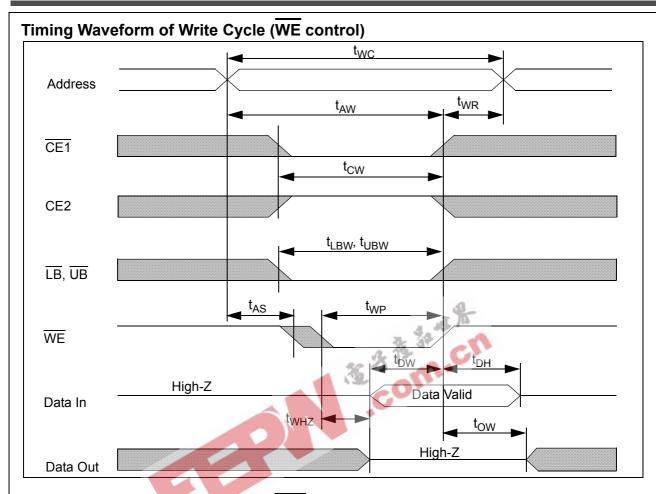


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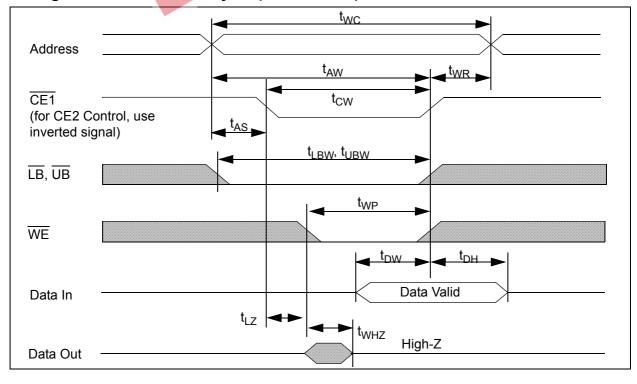


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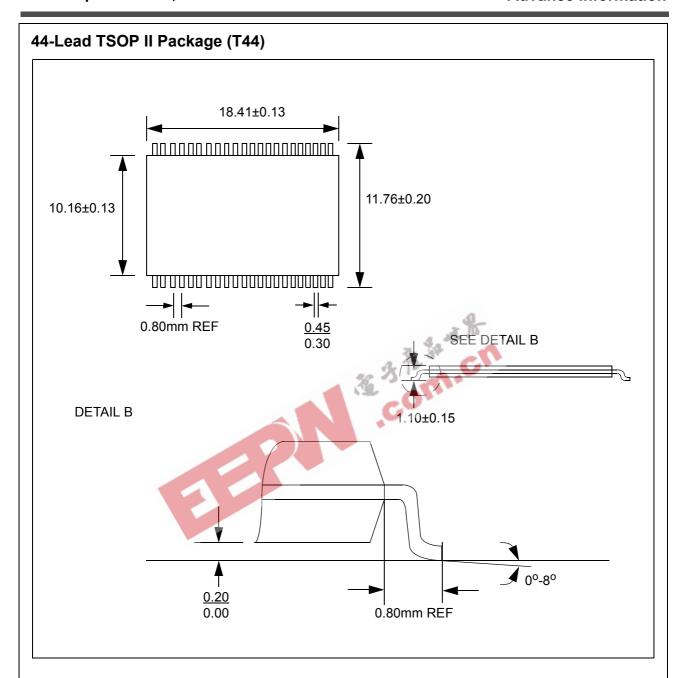
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Timing Waveform of Write Cycle (CE1 Control)



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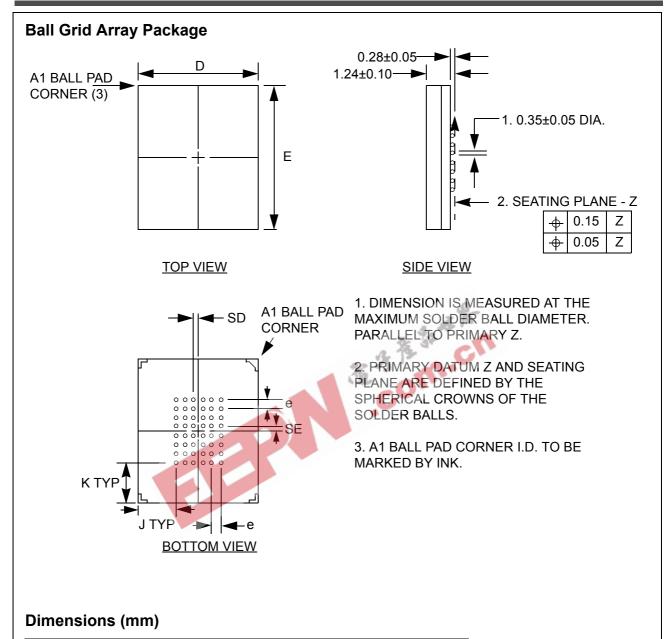
Note:

- 1. All dimensions in inches (Millimeters)
- 2. Package dimensions exclude molding flash

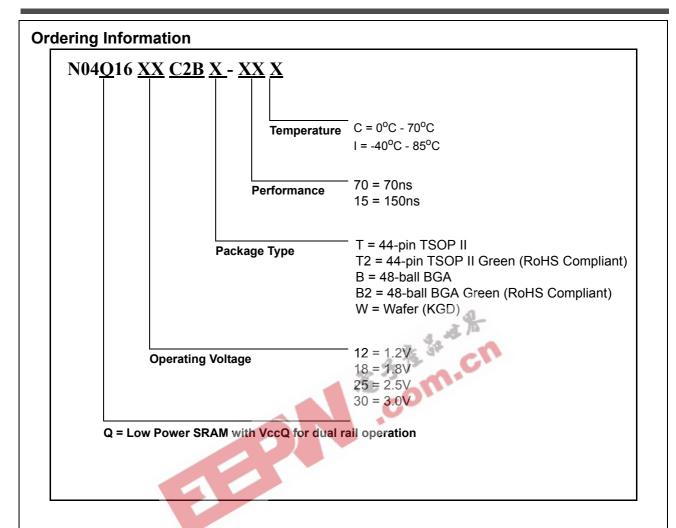
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D	F	e = 0.75				
	_	SD	SE	J	K	MATRIX TYPE
6±0.10	8±0.10	0.375	0.375	1.125	1.375	FULL



Revision History

Revision	Date	Change Description			
Α	October 2005	Initial Advanced Release			
В	February 2006	Raised maximum Vcc to 3.6V for 3V device Added green packages Changed dual rail to 'Q' part designator			

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